

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10590209	NAVEN ET AL.
Examiner	Art Unit	
IQBAL ZAIDI	2464	

SEARCHED

Class	Subclass	Date	Examiner
370	230, 503	08/11/09	iz
709	203	08/11/09	iz
370	230-253, 503	03/08/2010	iz
370	230-253, 503	08/20/2010	iz
370	229-238, 252-253, 389-427, 466-473	04/05/2011	iz
709	235	04/05/2011	iz
370	229-238, 252-253, 389-427, 466-473	10/17/2011	iz
709	35	10/17/2011	iz
370	229-238, 252-253, 389-427, 466-473	01/06/2012	iz

SEARCH NOTES

Search Notes	Date	Examiner
370(text search only- see search history)	08/10/09	iz
EAST(USPAT, USPPGPUB, EPO, USOCR, FERS, JPO, DERWENT	08/10/09	iz
Inventor and assignee search in EAST- see search history, Google, IEEE	08/10/09	iz
370(text search only- see updated search history)	03/08/2010	iz
Inventor and assignee search in EAST- see search history, Google, IEEE	03/08/2010	iz
EAST(see updated search)	08/18/2010	iz
Google, IEEE	08/18/2010	iz
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EAST(see updated search)	10/17/2011	iz
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EAST(see updated search)		
Inventor and assignee search in EAST- see search history, Google, IEEE	01/07/2012	iz
Application discussed with (PAO)	01/07/2012	iz

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
370	All	01/07/2012	iz